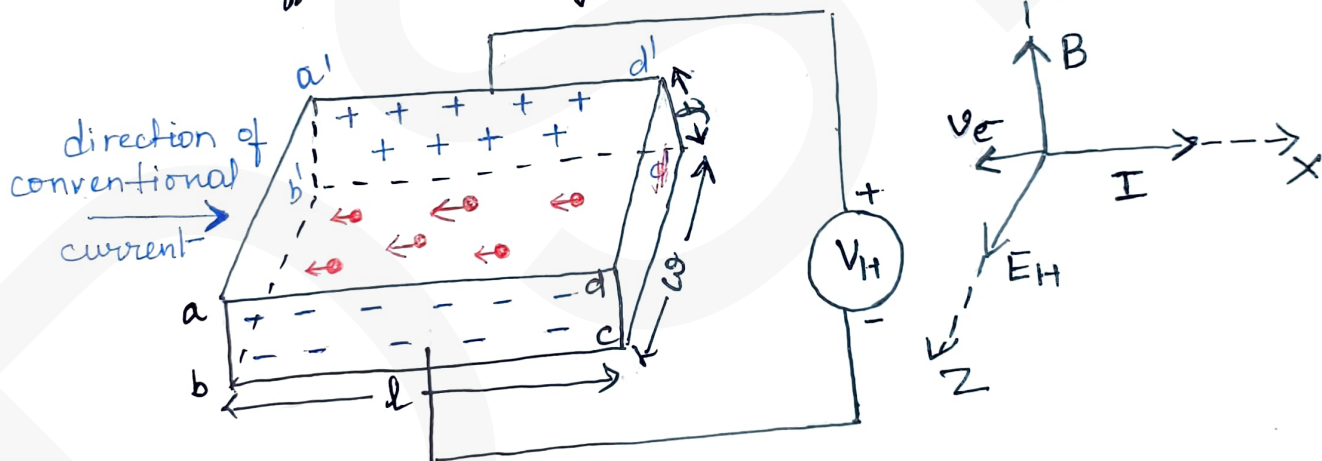


Hall Effect-

①

When a magnetic field is applied perpendicular to a current carrying conductor, a voltage is developed in the specimen, across the width of the specimen which generates electric field perpendicular to both the current and the magnetic field. This phenomenon is called as "Hall effect" and the generated voltage is called "Hall voltage". The corresponding transverse electric field is "Hall field".

Hall effect in n type semiconductor



- * Consider a rectangular shaped semiconductor material with width w , thickness t and length l , through which current I is flowing along $+x$ axis.
- * It is placed in magnetic field acting along y axis.
- * A voltmeter is connected across the front & back face of semiconductor i.e. along z -axis.

The carriers of negative charge (electrons) moving with an average velocity v , feels the action of Lorentz force given by $\vec{F}_L = q(\vec{v} \times \vec{B})$

or $|\vec{F}_L| = evB$ — (1) [$\because q = -e$ for n type semiconductor & we are taking magnitude alone]

Due to the force acting on electrons, they are deflected outwards and accumulate on face abcd of slab.

Due to polarity opposite face of abcd is positively charged.

A potential difference is created between the plates, which is Hall voltage V_H .

Due to Hall effect- transverse electric field E_H develops along Z axis.

Force due to E_H is given by $\vec{F}_H$ &

$$|F_H| = eE_H \text{ — (2)}$$

To prevent further accumulation of charge, $\vec{F}_H$ produced due to $\vec{E}_H$ balances force $\vec{F}_L$.

$$\therefore \quad (1) = (2) \Rightarrow |F_H| = |F_L|$$

$$\text{or} \quad evB = eE_H.$$

$$\text{or} \quad \boxed{v = \frac{E_H}{B}} \text{ — (3)}$$

②

Further, to obtain relation between Hall coefficient and Hall voltage,

current density $\vec{J}$ given by I/A where I is the current flowing in the slab and A is the cross section area i.e. area $\perp$ to the flow of current is given by —

$$\vec{J} = nq\vec{v} \quad \text{or} \quad J = -nev \quad [\because q = -e \text{ for } n \text{ type semiconductor}]$$

$$\text{or} \quad \frac{I}{A} = -\frac{neE_H}{B} \quad [\text{from (3)}]$$

$$\text{or} \quad \frac{I}{w \times t} = -\frac{neE_H}{B}$$

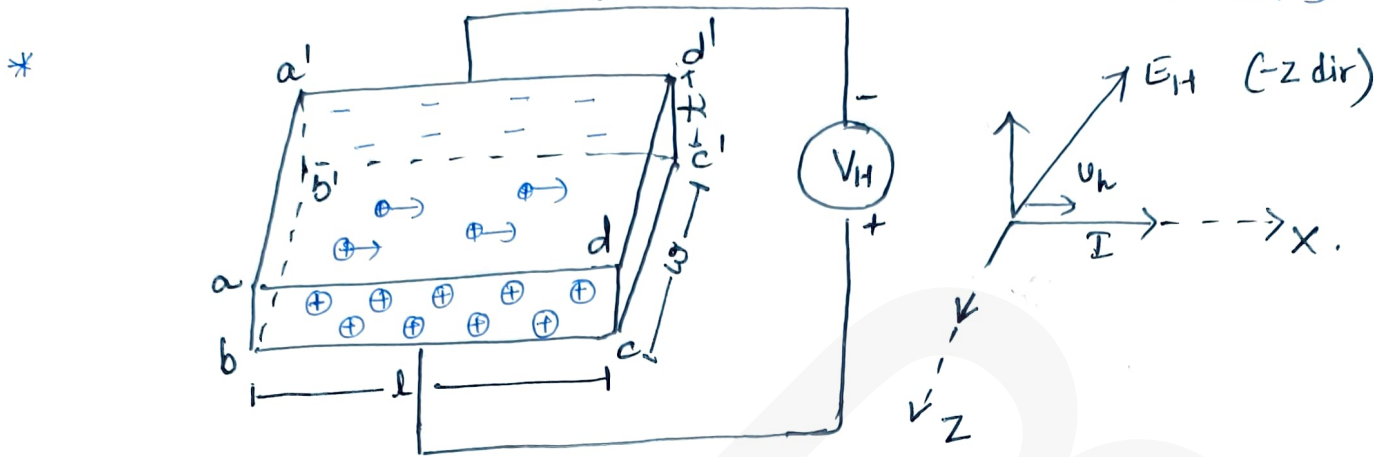
$$\text{or} \quad \frac{I}{w \times t} = -\frac{nev_H}{B \times w} \quad \left[\because E_H = \frac{V_H}{w} \right]$$

$$\text{or} \quad \boxed{V_H = -\frac{1}{ne} \frac{IB}{t}}$$

Here $-\frac{1}{ne}$ is R_H the Hall coefficient for n type semiconductor.

$$\therefore \quad \boxed{V_H = R_H \frac{IB}{t}}$$

Hall effect in p type semiconductor (refer fig 1)



- * Consider a rectangular shaped semiconductor material with width w , thickness t and length l , through which current I is flowing along $+ve$ x axis.
 - * It is placed in magnetic field acting along y axis.
 - * A voltmeter is connected across the front & back face of the semiconductor i.e. along z -axis.
 - * The carriers of positive charge, holes moving with an average velocity v , feels the action of Lorentz force given by $\vec{F}_L = q(\vec{v} \times \vec{B})$.
- $$\text{or } |\vec{F}_L| = evB \quad \text{--- (1)}$$
- * Due to The force acting on ~~the~~ holes, They are deflected outwards and accumulate on face $abcd$ of slab.
 - * Due to polarity opposite face is negatively charged.

* A potential difference is created between the plates, ⁽³⁾ which is Hall voltage V_H .

→ Due to Hall effect transverse electric field E_H develops along $-z$ axis.

Force due to E_H is given by $\vec{F}_H$ & .

$$|F_H| = e E_H \quad \text{--- (2)}$$

To prevent further accumulation of charge, $\vec{F}_H$ produced due to $\vec{E}_H$ balances force $\vec{F}_L$.

$$\therefore \quad \textcircled{1} = \textcircled{2} \Rightarrow |F_H| = |F_L|$$

$$\text{or } evB = eE_H.$$

$$\text{or } \boxed{v = \frac{E_H}{B}} \quad \text{--- (3)}$$

To obtain relation between Hall coefficient & Hall voltage -
Current density $\vec{J}$ given by I/A where I is the current flowing in the slab and A is the cross section area i.e. area $\perp$ to the flow of current is given by -

$$\vec{J} = nq\vec{v} \quad \text{or } J = nev \quad \left[\because q = e \text{ for p type semiconductor} \right]$$

$$\text{or } \frac{I}{A} = \frac{+ne E_H}{B} \quad (\text{from (3)})$$

$$\text{or } \frac{I}{w \times t} = \frac{ne V_H}{B \times w} \quad \left[\because E_H = \frac{V_H}{w} \right]$$

$$\text{or } \boxed{V_H = \frac{1}{ne} \frac{IB}{t}}$$

Here $\frac{1}{ne}$ is R_H - the Hall coefficient for p type semiconductor.

$$\therefore \quad \boxed{V_H = R_H \frac{IB}{t}}$$

APPLICATIONS OF HALL EFFECT

- * Hall effect is used to find whether a semiconductor is N type or P type.
- * Hall effect is used to find carrier concentration.
- * Hall effect is used to calculate the mobility of charge carriers (free e^- s and holes)
- * Hall effect is used to measure conductivity.
- * Hall effect is used to measure strength of magnetic field.
- * Hall effect is used in an instrument called Hall effect multiplier which gives the output proportional to the product of two V/P signals.